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Abstract. Even prior to the recent advent of advanced top-down processes, shadowing growth by oblique angle deposition (OAD) has long been providing self-assembled nanostructures over much larger areas for much lower costs. In the past two decades, significant progress has been made in the development of well-controlled three-dimensional nanomorphologies such as zig-zags and helixes. Much effort has been put into theoretical and numerical understanding of the growth mechanism to improve morphology. Many researchers in academia have been investigating useful properties of nanocolumnar thin films in their laboratories. However, most companies seem hesitant to introduce OAD techniques into the factory, owing to the prejudice that the OAD thin films are neither durable nor reproducible. The progress in OAD technology for practical applications is reviewed and discussed. © The Authors. Published by SPIE under a Creative Commons Attribution 3.0 Unported License. Distribution or reproduction of this work in whole or in part requires full attribution of the original publication, including its DOI. [DOI: [10.1117/1.JNP.7.073598](https://doi.org/10.1117/1.JNP.7.073598)]

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1 Introduction

The excellent textbook authored by Lakhtakia and Messier¹ teaches us that today's major thin film deposition technologies, such as sputtering² and thermal evaporation,³ originated in the middle of the 19th century. Since then, research and development on thin films has continued for more than 150 years. Today, thin film technologies have matured to the extent that thin films can be deposited over very large areas with excellent uniformity.^{4,5} In most recent practical thin films, functionalities originating from the materials' own properties and uniformity, without internal structures larger than the nanometer scale, are well established.

However, if we can control the internal nanomorphology in a well-reproducible manner, various useful properties might be added to the existing functionalities owing to the materials' own properties. Although lithographic technologies are significantly developed, it is still difficult to form three-dimensional (3-D) nanomorphologies over large areas at low cost. On the other hand, one can self-assemble a 3-D nanomorphology by taking advantage of the thin film growth mechanism. One of the most powerful methods for controlling nanomorphology is oblique angle deposition (OAD) or glancing angle deposition (GLAD). Although the advanced functionalities of OAD films are well understood in academia, there seems to be prejudice in the industry that OAD thin films are neither durable nor reproducible. However, in the past few years, very fortunately, new products produced by the OAD technique have appeared on the market, including a substrate for surface-enhanced Raman spectroscopy⁶⁻⁸ and a low-reflectivity wire-grid polarizer.^{9,10} In this article, we discuss the practicability of OAD thin films and examples of the products produced by the OAD technique.

2 Example of OAD Thin Films and their Growth Mechanism

About 30 years after the major physical vapor deposition (PVD) techniques were developed, Kundt¹¹ had already published the first report on OAD thin films.¹ Because of the significant development of transmission electron microscopy (TEM), OAD thin films were investigated intensively during the 1960s. At present, research in this field is in its second century.

Fig. 1 (a)–(f) Typical examples of the nanocolumnar structures of OAD thin films^{8,14–16}, and (g) a schematic drawing of the deposition geometry.

Many of the active investigations on OAD thin films in the past two decades originated after the development of chevron- and helix-shaped columns by Motohiro and Taga¹² and Robbie et al.,¹³ respectively.

Here, we briefly introduce examples of OAD thin films (Fig. 1).^{8,14–16} During conventional PVD, the vapor is deposited on a substrate from the normal direction in vacuum so that flat, uniform thin films are produced. In contrast, during OAD, the substrate is set obliquely and sometimes rotated in-plane, as shown in Fig. 1(g). If the substrate temperature is sufficiently low, unique nanocolumnar structures such as zigzags, helixes, posts, and complex hybrid structures are created [Fig. 1(a)–1(e)].

The physical origins of the columnar structure in OAD thin films are self-shadowing effects and the limited mobility of the deposited atoms. When the vapor flux is obliquely incident on the substrate surface, atoms in the growing films shadow unoccupied sites from the direct sticking of incident atoms [“shadowing effect,” Fig. 2(a)]. Moreover, owing to limited mobility, the unoccupied sites are not filled later [Fig. 2(b)]. As a result, oblique columns grow in the direction of the incident vapor beam [Fig. 2(c)]. The growth direction can be varied by changing the incident direction of the vapor flux.

Fig. 2 Schematic illustrations of the growth mechanism of the nanocolumnar structures: (a) nucleation, (b) onset of self-shadowing, and (c) nanocolumnar growth.

From the viewpoint of nanomorphological control, significant progress has been made in precise control^{17,18} and integration of shapes.^{16,19,20} In addition, many novel phenomena, especially unusual crystal growth^{21,22} induced by OAD, have been discovered.

Owing to these well-controlled nanocolumnar morphologies, it has been well known that OAD thin films show shape-related anisotropy such as birefringence,^{1,12,23,24} dichroism,^{25,26} and magnetic anisotropy.^{27–29} Various advanced properties of OAD thin films have also been reported.^{14,30–33} For example, large surface area and high porosity are quite useful for surface chemical reactions,¹⁴ biochemical sensors,³² gas sensors,³³ etc. These properties are also very attractive for practical applications.

However, only a few OAD thin film products are currently available. The most successful example is the video tape.²⁹ Other than the video tape, metal polarizers^{34,35} and birefringent coatings^{12,36} are also available. Apart from these examples, few products have been produced using the OAD technique. Most companies seem hesitant to introduce OAD into the factory. We believe that this is due to skepticism about the durability and reproducibility of OAD thin films. Thus, in the next section, we discuss the practicability of OAD thin films.

3 Practicability of OAD Thin Films

When new materials are considered for introduction into practical devices, one requires functionality, productivity, and reliability. In the case of OAD thin films, many unusual and useful properties are available. Thus, let us consider the practicability of OAD thin films that have useful functionalities.

3.1 Productivity of OAD Thin Films

Many researchers and engineers ask, “Can OAD thin films be mass-produced?” The answer is “Yes.” Many optical coatings are produced in a batch-type coater. Inside the deposition chamber, there are some evaporation sources and a large (typically 2 m in diameter) dome-shaped substrate holder. Such a substrate holder can carry hundreds of substrates. If the substrate holder is slightly modified, mounting the substrates obliquely and using planetary rotation are possible. Therefore, it is neither difficult nor very expensive to modify the standard coater for mass production of OAD thin films. However, unfortunately, we cannot avoid the decrease in the deposition rate. For example, at a deposition angle of 70 deg, the deposition rate becomes 1/3 of the normal deposition rate. This might lead to slightly high cost for OAD films. However, by inputting slightly higher power to the deposition source, one can compensate for the decrease in the deposition rate. Consequently, mass production of OAD thin films is not a severe problem for practical applications.

3.2 Reliability of OAD Thin Films

Many people who consider application of OAD thin films worry about their reliability. However, many, although not all, OAD thin films have sufficient reliability. For example, Fig. 3 shows photographs of a Ta₂O₅ waveplate deposited in 1998³⁶ and kept in ambient conditions in the author's office for more than 10 years. This film was deposited by using the Motohiro-Taga

Fig. 3 Visual appearance of a waveplate of an OAD Ta₂O₅ thin film³⁶ taken (a) without and (b) with commercial sheet polarizers.

Fig. 4 SEM images of TiO_2 thin films prepared at (a and a') $\alpha = 70^\circ$ and (b and b') $\alpha = 82^\circ$. The samples of (a) and (b) are as-deposited and the samples of (a') and (b') are processed in water vapor at 120°C and 90% RH.³⁷

process¹² at a deposition angle of 70° and has a chevron-shaped columnar cross-section. As indicated in Fig. 3(a), the film is completely transparent. From the photograph taken through polarizers shown in Fig. 3(b), it is clear that the retardation properties are quite uniform. Therefore, the film is very durable and exhibits high uniformity over 100 cm^2 . In addition, such a film is well reproducible because it was prepared by physical processes.

Another example is shown in Fig. 4. Generally, porous thin films are fragile. However, in many applications of thin films, the surface of the film is protected by a package or passivation coating. Users do not touch the surface of the OAD thin films in many cases. Remarkably, under some severe conditions, films with isolated columns are more stable than dense films. The scanning electron microscopy (SEM) images in Fig. 4(a') and 4(b') are those of columnar TiO_2 thin films processed under high-temperature air and water vapor.³⁷ For the thin films with closely distributed columns, the columnar structure is destroyed by exposure to hot water vapor [Fig. 4(a')]. In contrast, the thin films with isolated columns show no significant change in their morphologies [Fig. 4(b')]. Therefore, the durability of OAD thin films is sufficient for appropriate applications.

3.3 Designability

Manufacturers are extremely wary of production problems from unknown causes. Therefore, they often ask us, "Is the growth mechanism fully understood?" The answer may be, "Not fully, but sufficient to design the deposition process." The complex shapes in OAD thin films can be reproduced by numerical simulations.^{15,38} The model is rather simple; that is, the deposition process is ballistic. Surface diffusion of the particles sticking to the surface is modeled by random walks. By using a Monte Carlo simulation based on this simple model, morphologies of the OAD films can be well reproduced.

Monte Carlo simulations are also useful for designing film properties. Figure 5 indicates the results of work on developing Si rugate filters.¹⁵ If the deposition angle is changed during the deposition, the density can be changed continuously. When the deposition angle is large, the density becomes low and vice versa. Thus, we can control the refractive index continuously and create rugate optical filters by using only a single material.

Fig. 5 (a) SEM image of a Si rugate filter prepared based on the process designed by simulation, (b) the cross-sectional morphology of a simulated film, (c) depth profile of the packing density of the simulated film, and (d) comparison between the transmittance spectra of simulated and measured films.¹⁵

After some preliminary experiments, we prepared Si optical filters based on the process designed by Monte Carlo simulation. Figure 5(b) shows the cross-section of the designed film, and Fig. 5(a) shows a SEM image of the real film. The results, including the absolute film thickness, agree well with each other. Figure 5(d) displays the measured and designed transmittance spectra. Agreement between the measurement and design is excellent. Hence, the structure and properties of OAD films can be designed.

OAD thin films thus have many advantages from the viewpoint of their functionality, while their weak points do not pose severe problems for practical applications. Therefore, if the prejudice on the part of manufacturers is removed, more OAD thin films can be expected to enter the market. In fact, we have succeeded in introducing new OAD products into the market by discussing these points with our collaborators in manufacturers.

4 Examples of Recent Practical Applications

4.1 Au Nanorod Arrays for Surface-Enhanced Raman Scattering

Much attention has been devoted to surface-enhanced Raman scattering (SERS) in the near-IR (NIR) region from the viewpoint of applications to biochemical sensors. SERS is a direct and very sensitive method for identifying molecules. It is well known that the local electric field enhanced by the plasma resonance in metal nanoparticles plays an important role in the strong enhancement of Raman scattering. For application to biological materials, the excitation in the NIR region is appropriate because this region is compatible with biological tissues' transparency

window.³⁹ To develop NIR SERS substrates, the control of size, shape, and arrangement of nanoparticles is important.

Elongated nanoparticles (so-called nanorods) are strong candidates for NIR SERS substrates because the local field can be significantly enhanced at their ends. Sensitive SERS properties of lithographically produced nanorod arrays have been reported.^{40,41} However, the high cost of these top-down processes has not yet been overcome. Although chemically produced nanorods also have tunable and very uniform shapes,⁴² they get distributed randomly on the substrate. As a result, not all nanorods align end to end, where further enhancement of the local field is expected. Nanorods created by simple OAD align side by side.⁴³ However, we have succeeded in aligning the nanorods end to end by using OAD.⁴⁴

Figure 6(a) shows the morphology of our Au nanorod arrays. Au nanorods were aligned on a SiO₂ template layer (called the “shape control layer”) having an anisotropic surface morphology prepared by OAD.⁶ The shape control layer of SiO₂ as the template for Au nanorods is prepared by a serial bideposition (SBD) technique. The glass substrate is set obliquely at a deposition angle of about 80 deg. During deposition, the substrate is rotated in-plane by 180 deg with each deposition of 10 nm of SiO₂. As a result, the surface of the shape control layer prepared by SBD is corrugated anisotropically.^{6,7} On the anisotropic shape control layer, Au is also evaporated obliquely in vacuum. The amount of deposited Au is only around 10 nm thick on average. The Au sticks only to the top of the columns, owing to shadowing, and forms elongated nanoparticles (nanorods). Excellent SERS properties are observed, as indicated in Fig. 6(b), when the Raman spectra are measured on the Au nanorod arrays immersed in a solution of 4,4'-bipyridine.⁶ The SERS spectra can be detected down to 1 μ M of solution within a few minutes after the immersion of samples. In our measurement system, the spot size of the laser is around 1 μ m². The thickness of the nanorod array is of the order of 10 nm. Therefore, at 1 μ M, the number of molecules existing inside the SERS active volume is estimated to be fewer than 10 molecules. Thus, our nanorod arrays have a detection sensitivity of nearly a single molecule.

Fig. 6 (a) SEM image of a Au nanorod array prepared on the OAD SiO₂ template layer and (b) the SERS spectra measured on a Au nanorod array in a 1 mmol/l solution of 4,4'-bipyridine.⁶

The high sensitivity can be attributed to the high number density of nanorods and effective field concentration between in-line aligned nanorods.

In addition to the high sensitivity, our nanorod arrays are well reproducible, and no contamination occurs during deposition. Moreover, they maintained high SERS sensitivity for more than one year.⁶ These are the advantages of the OAD technique. Fortunately, a Japanese coating company recently began to produce our nanorod arrays. These are already available on the market today.

4.2 Low-Reflectivity Wire-Grid Polarizers

Recent liquid-crystal (LC) projectors require high thermal durability for their optical elements. Metal wire-grid (WG) polarizers are quite suitable because they are not degraded by heat and light.⁴⁵ In addition, high reflectivity of the wire-grid polarizers is useful for recycling the light near the light source. However, highly reflective polarizers downstream might generate stray light, which might degrade image quality. Therefore, polymer sheet polarizers have been used in projectors and their durability significantly influences the lifetime of the total system. Thus, improving the brightness and durability of projectors requires the development of low-reflectivity (LR) WG polarizers. In other words, antireflective (AR) coatings for nanostructured metals are needed.

From considerations based on optical admittance, we found that antireflectivity is always possible if we fabricate a multilayered thin film of absorptive and dielectric materials on a highly reflective metal.⁹ This bilayered AR concept has been applied to reduce the reflectance of WG polarizers made of Al.

Fig. 7 (a) SEM image of a low-reflectivity wire-grid polarizer, (b) its layered structure, and (c) the reflectance and transmittance spectra.⁹

At first, we prepare aluminum WG polarizers by interference lithography and dry etching. The dielectric layer of SiO_2 is deposited by ordinary sputtering. The absorptive layer of FeSi_2 is then deposited by ion beam sputtering at a glancing deposition angle of 87 deg from the surface normal. Because of the shadowing effect, the sputtered FeSi adheres only to the top of the WGs covered with SiO_2 .

Figure 7(a) and 7(b) shows SEM images of an LR-WG polarizer.⁹ The thicknesses of FeSi_2 and SiO_2 are 10 and 24 nm, respectively. The wires show bulges growing toward the incident direction of FeSi_2 . This suggests that the bulges correspond to nanoparticles of deposited FeSi_2 . Thus, it is expected that elongated FeSi_2 nanoparticles are arrayed on the Al WG covered with the dielectric layer of SiO_2 . Similar structures can be fabricated, in principle, by conventional top-down processes. However, etching multilayers consisting of materials with very different properties is not easy, whereas OAD is robust in terms of selection of materials. In addition, the fact that conventional WG polarizers can be converted to LR-WG polarizers by simply depositing SiO_2 and FeSi_2 is useful. Figure 7(c) indicates the reflectance and transmittance spectra of an LR-WG polarizer. Clearly, the reflectance of both TE and TM waves is very small. No significant degradation of the transmission properties is recognized. The extinction ratio of the LR-WG polarizers is slightly higher than the conventional WG polarizers and reaches 1500 to 2000.¹⁰ Because LR-WG polarizers are completely composed of inorganic materials, they are much more durable than polymer polarizers. The durability of the LR-WG polarizers is basically identical to that of the conventional WG polarizers.⁴⁵ Our LR-WG polarizers are now used in commercial LC projection displays that require high thermal durability.

5 Summary

We reviewed the recent status of practical applications of OAD thin films. To remove the skepticism and prejudice of manufacturers, the practicability of OAD thin films was discussed. There are no significant problems in their production, reliability, and designability, which are important considerations for practical applications. In addition, we introduced two examples of our recent practical applications: Au nanorod arrays for SERS and low-reflectivity wire-grid polarizers. Both products are currently available on the market.

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